## **CLAIMS**

1. A film forming method comprising:

reacting a hafnium organic compound and a silane-series gas in a reaction vessel, thereby depositing a hafnium silicate film on a substrate.

- 2. The film forming method according to claim 1, wherein a heated atmosphere is established in an interior of the reaction vessel, and the hafnium organic compound is supplied into the reaction vessel in a vapor state.
- 3. The film forming method according to claim 1 or 2, wherein the silane-series gas comprises monosilane gas and/or disilane gas.
- 4. A film forming method comprising:

depositing a hafnium compound film containing hafnium and oxygen on a substrate; and

annealing the hafnium compound film, obtained by the depositing, in an atmosphere of a compound gas of nitrogen and hydrogen.

- 5. The film forming method according to claim 4, wherein the compound gas of nitrogen and hydrogen is ammonia gas.
- 6. The film forming method according to claim 4 or 5 further comprising:

depositing a silicon nitride film after the annealing of the hafnium compound film.

7. The film forming method according to any one of claims 4 to 6, wherein the hafnium compound film is a hafnium silicate film deposited by reacting a hafnium organic compound and a silane-series gas.

- 8. A film forming apparatus comprising:
  - a reaction vessel into which a substrate is loaded;
- a heating mechanism that heats an atmosphere in the reaction vessel;
- a first gas-supplying means for supplying a vapor of a hafnium organic compound into the reaction vessel;
- a second gas-supplying means for supplying a silane-series gas into the reaction vessel; and
- a controller that controls the heating mechanism and the first and second gas-supplying means to deposit a hafnium silicate film on a substrate by reacting the hafnium organic compound and the silane-series gas in the reaction vessel.